

Diamond crystal stress imaging using nitrogen-vacancy centers in diamond

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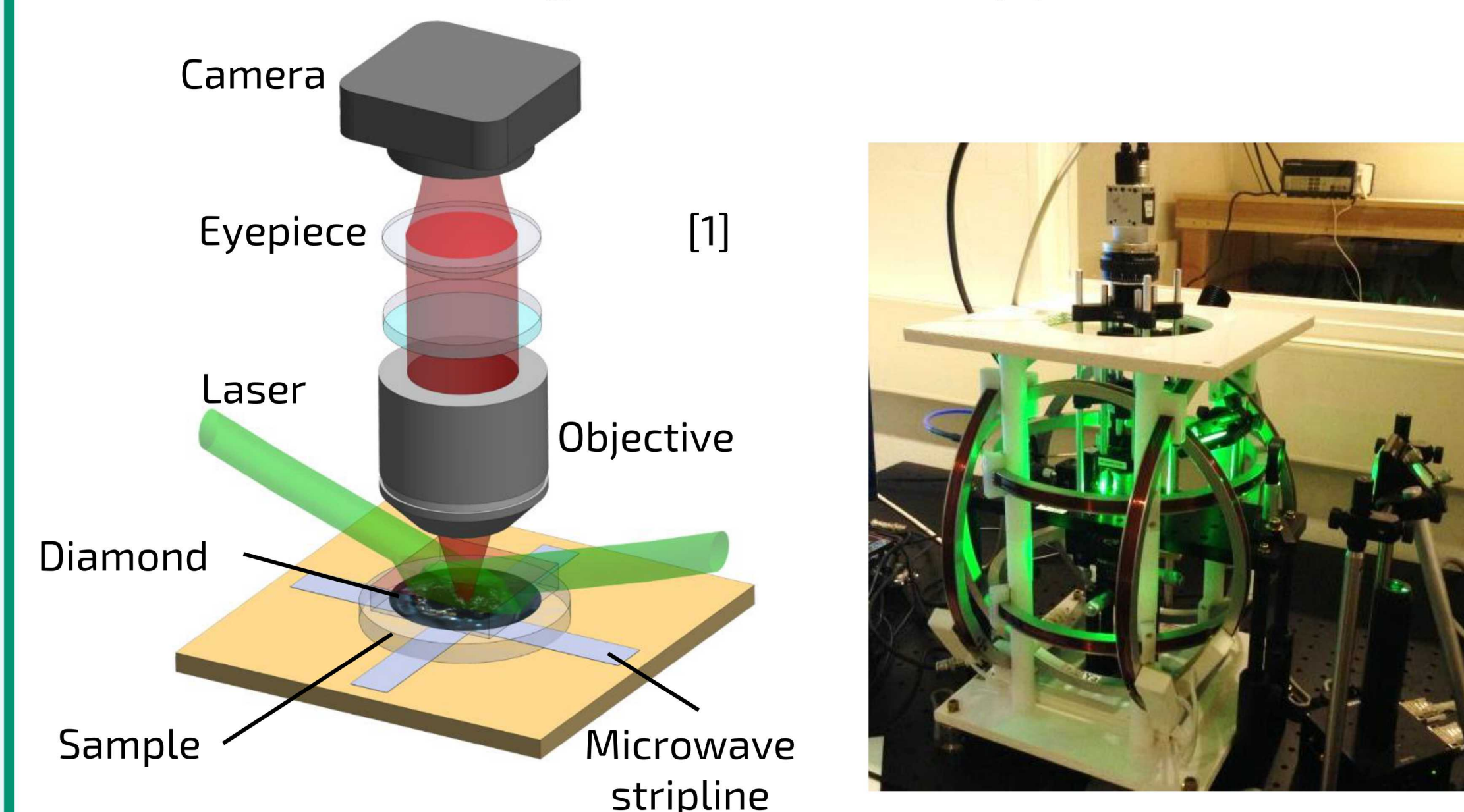


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Summary

- We use nitrogen-vacancy (NV) color centers in diamond for magnetic microscopy

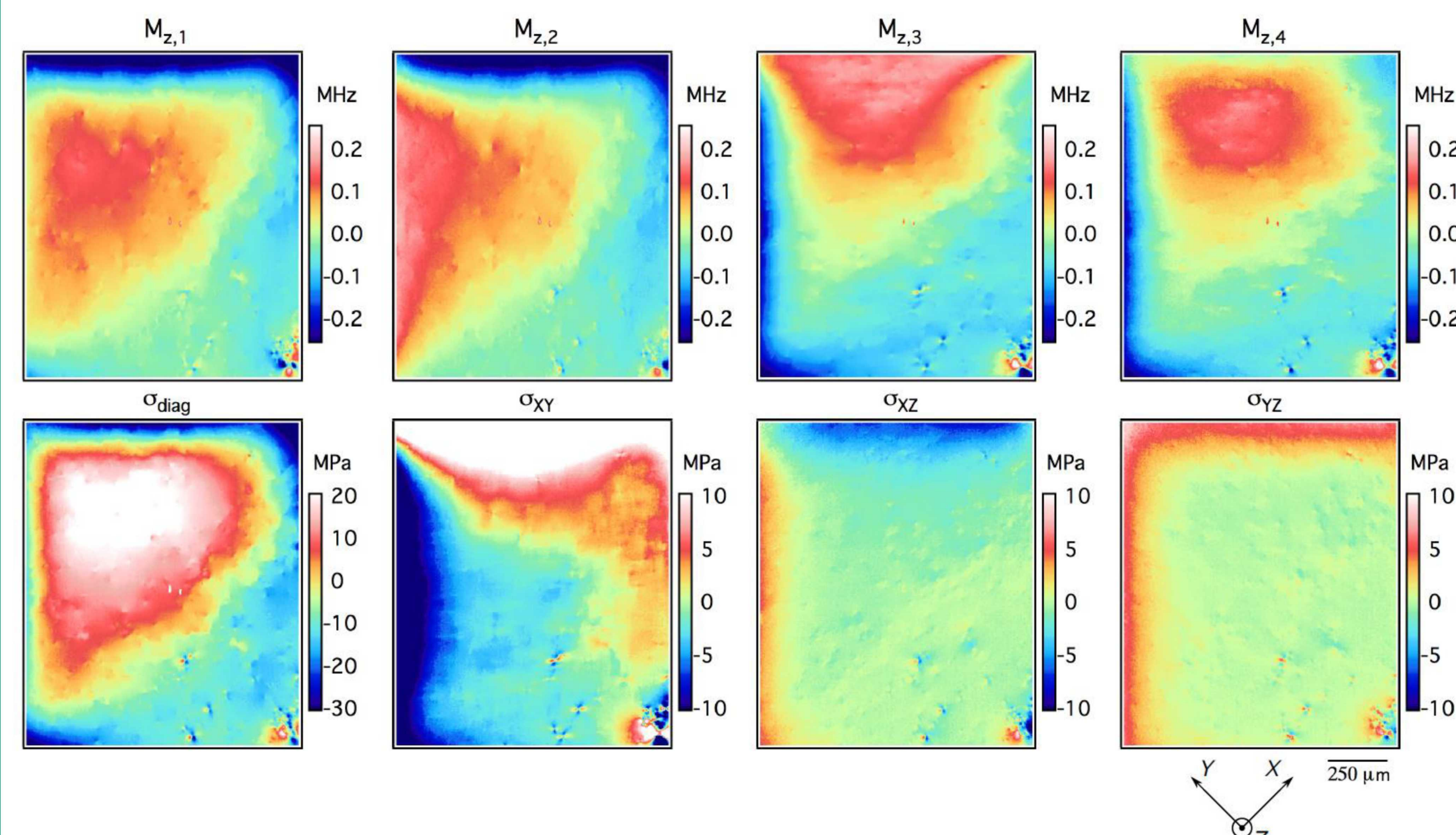


- Diamond crystal stress inhomogeneity can complicate NV magnetometry

Goals:

- Map the diamond stress tensors
- Study natural strain defects
- Understand their effects on NV magnetic imaging

Sample stress tensor reconstruction



- Homogeneous M_z is better for magnetic imaging
- Stress maps indicate diamond growth problems
- Usually get more stress in σ_{diag} and σ_{XY}

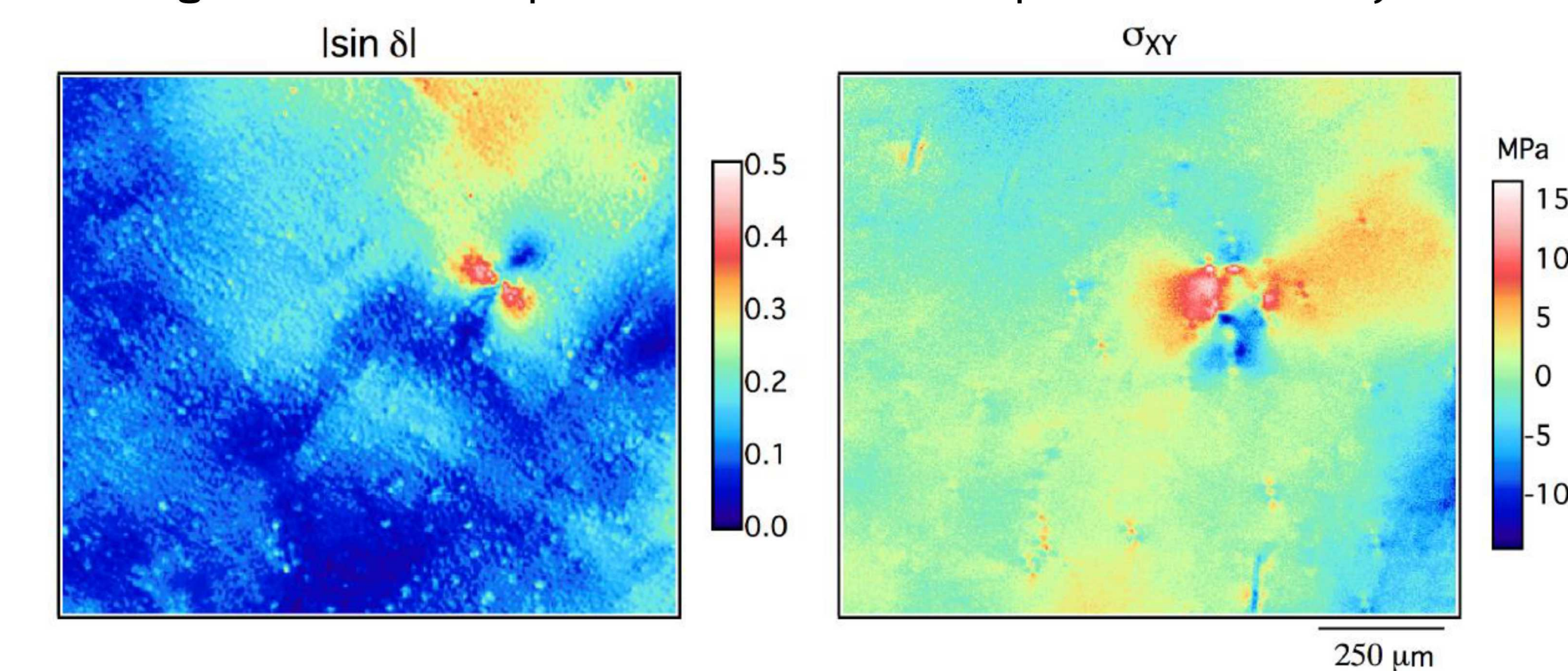
Comparison to birefringence imaging

Birefringence:

- + Works for transparent materials
- + Easier setup & faster measurement
- Integrate through diamond slab
- Phase ambiguity if $\delta > \pi$
- Nontrivial stress extraction
- Birefringence in other optics

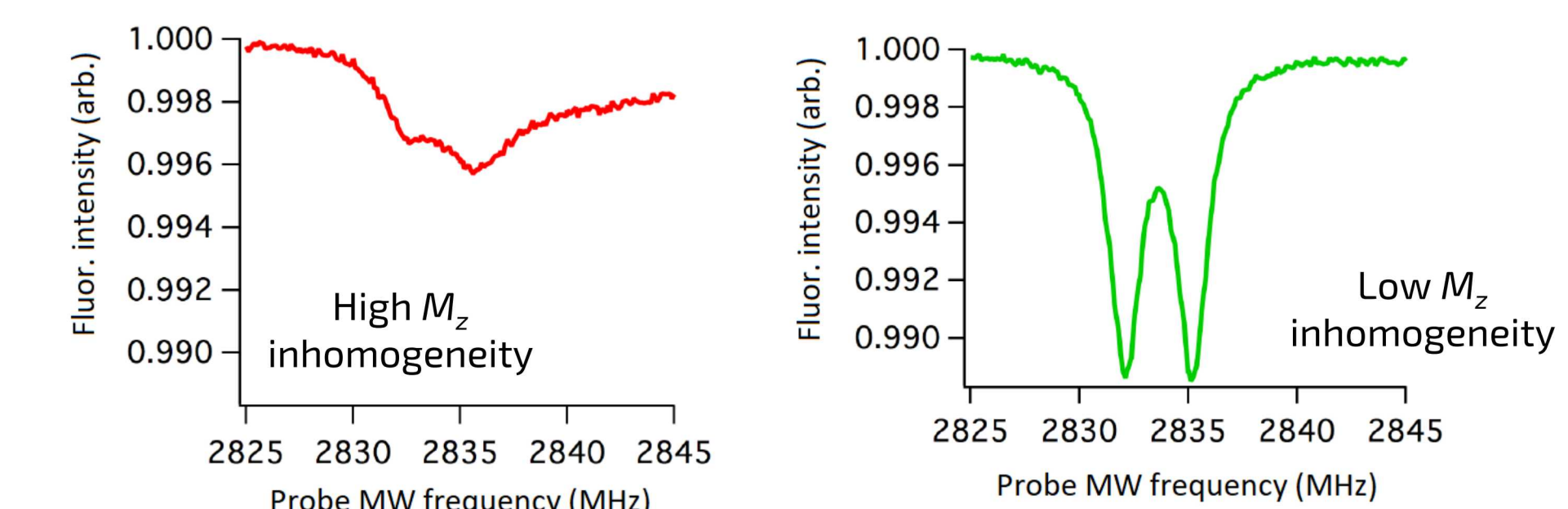
NVs:

- Need stress-dependent defects
- NV magnetic imager needed
- + Measure in NV layer only
- + No upper bound on stress*
- + Easy M_z to stress conversion
- Temperature stability

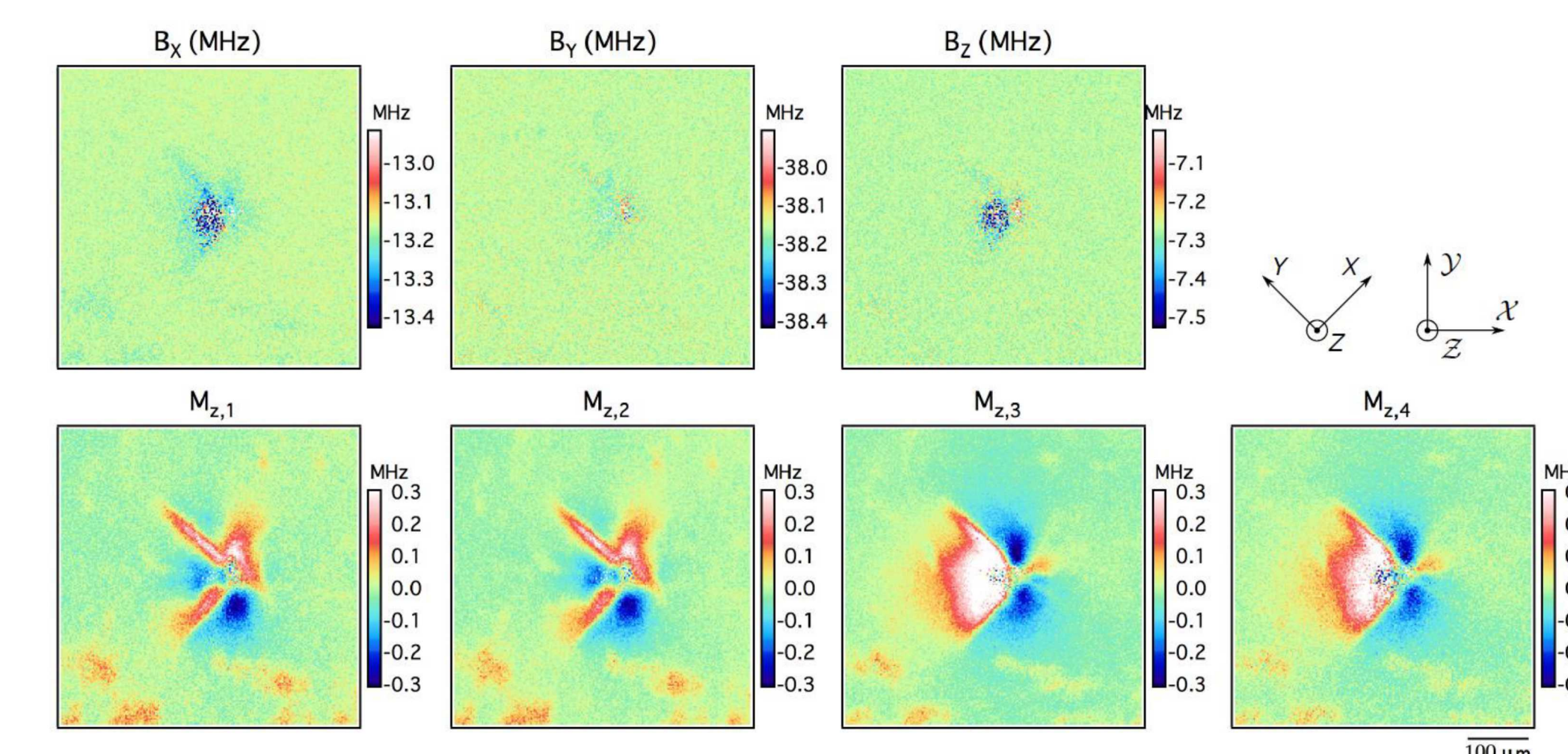


M_z inhomogeneity complicates magnetic imaging

- Single-pixel stress spoils NV T_2^* and contrast [6]



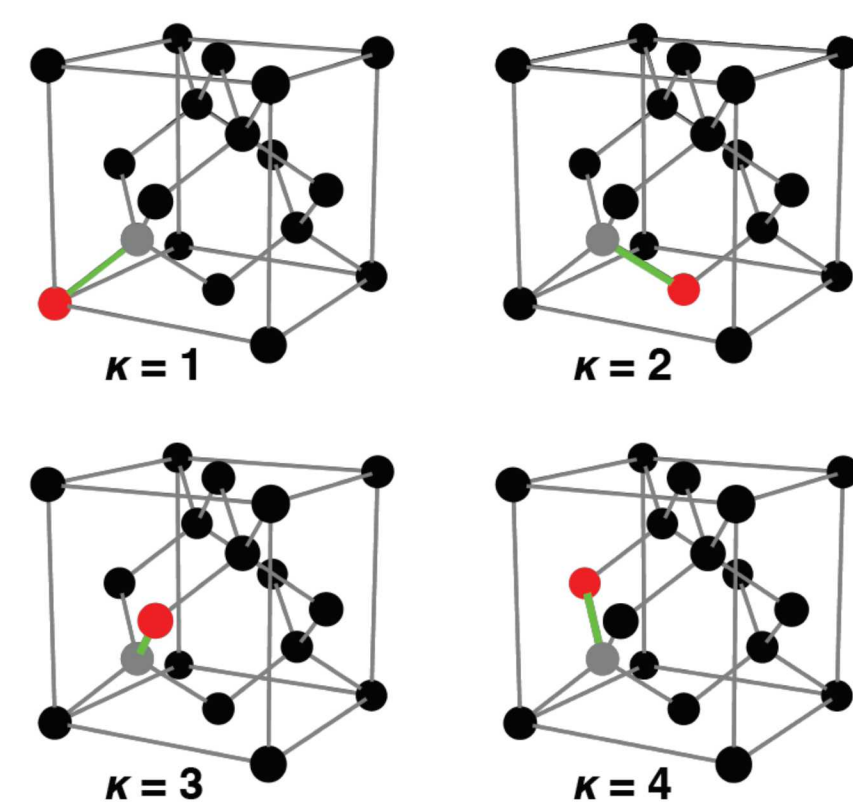
- Strain features creep into B field measurements



Stress contribution to NV Hamiltonian [2-5]

For each NV orientation:

$$H_{\kappa} = (D + M_{z,\kappa}) S_{z,\kappa}^2 + \gamma \vec{B} \cdot \vec{S}_{\kappa} + M_{xx,\kappa} (S_{x,\kappa}^2 - S_{y,\kappa}^2) + M_{yy,\kappa} (S_{y,\kappa}^2 - S_{x,\kappa}^2) + M_{zz,\kappa} (S_{z,\kappa}^2 - S_{x,\kappa}^2 - S_{y,\kappa}^2) + N_{xx,\kappa} (S_{x,\kappa} S_{y,\kappa} + S_{y,\kappa} S_{x,\kappa}) + N_{yy,\kappa} (S_{y,\kappa} S_{z,\kappa} + S_{z,\kappa} S_{y,\kappa}) + N_{zz,\kappa} (S_{z,\kappa} S_{x,\kappa} + S_{x,\kappa} S_{z,\kappa})$$

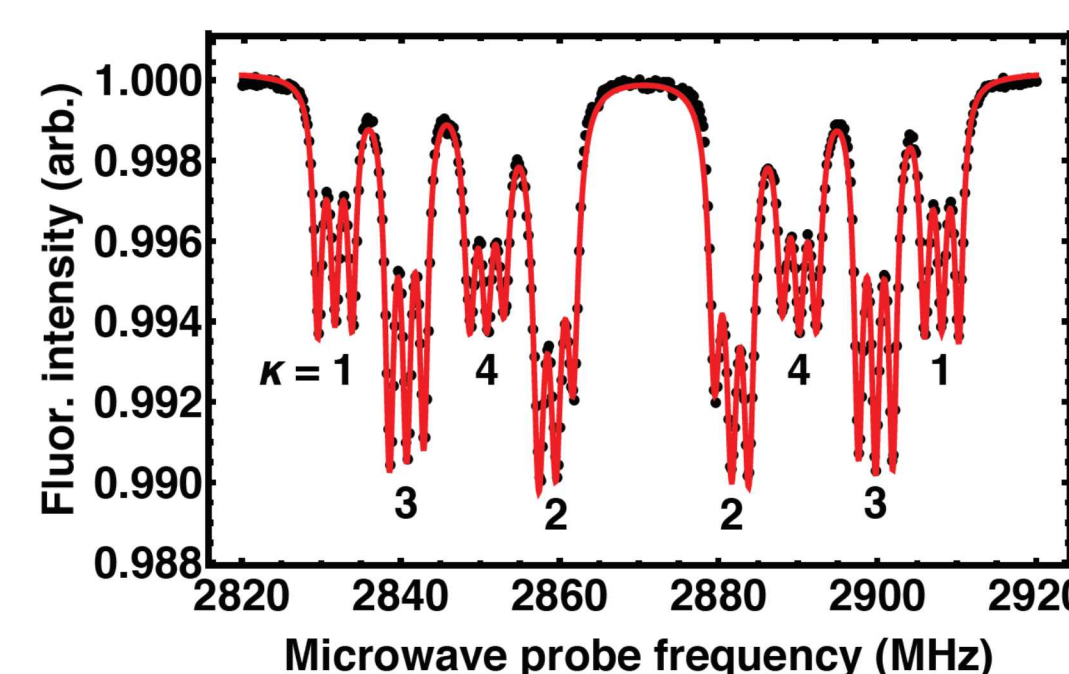


Stress tensor for $\kappa = 1$

$$\begin{pmatrix} \sigma_{XX} & \sigma_{XY} & \sigma_{XZ} \\ \sigma_{XY} & \sigma_{YY} & \sigma_{YZ} \\ \sigma_{XZ} & \sigma_{YZ} & \sigma_{ZZ} \end{pmatrix} \Rightarrow M_{z,1} = a_1 \sigma_{\text{diag}} + 2a_2 [\sigma_{XY} + \sigma_{XZ} + \sigma_{YZ}], \text{ where } \sigma_{\text{diag}} \equiv \sigma_{XX} + \sigma_{YY} + \sigma_{ZZ}, \{a_1, a_2\} = \{4.86, -3.7\} \text{ MHz/GPa}$$

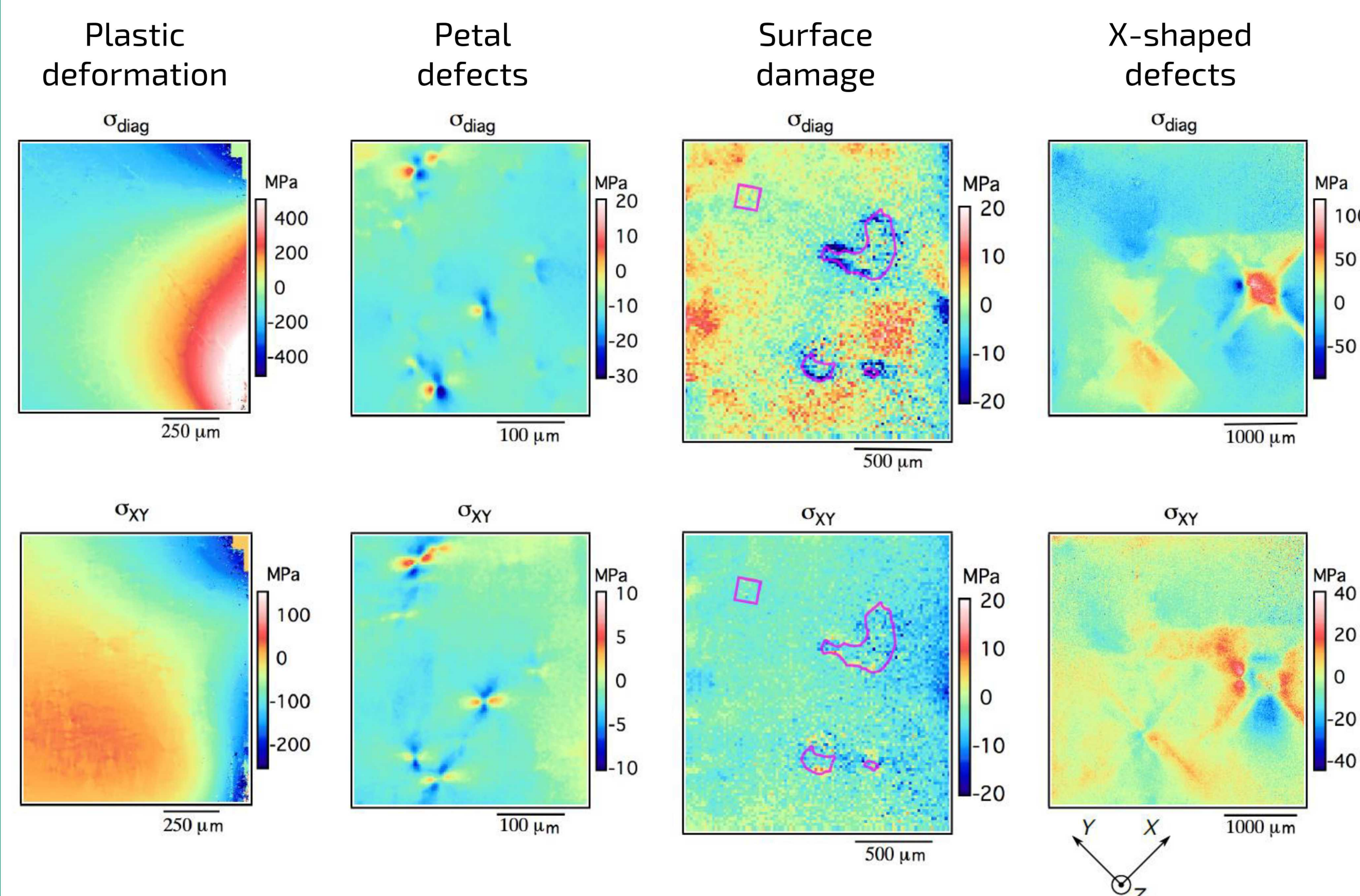
Repeat for each κ and solve:

$$\begin{aligned} \sigma_{\text{diag}} &= \frac{1}{4a_1} [M_{z,1} + M_{z,2} + M_{z,3} + M_{z,4}] \\ \sigma_{XY} &= \frac{1}{8a_2} [M_{z,1} + M_{z,2} - M_{z,3} - M_{z,4}] \\ \sigma_{XZ} &= \frac{1}{8a_2} [M_{z,1} - M_{z,2} + M_{z,3} - M_{z,4}] \\ \sigma_{YZ} &= \frac{1}{8a_2} [M_{z,1} - M_{z,2} - M_{z,3} + M_{z,4}] \end{aligned}$$



Strain feature survey

- Strain from edges, corners, lattice dislocations, and surface damage



References

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